

Special Issue

Air Contaminant Measurement in the Workplace

Message from the Guest Editors

This Special Issue involves research targeting strategies and techniques commonly used to conduct air contaminant sampling, measurement, and monitoring in occupational workplaces. Researchers who have conducted air contaminant studies using emerging and/or state-of-the-art sampling strategies, monitoring equipment and instrumentation, and data analysis techniques are encouraged to submit abstracts and papers for review. Topics that involve the use of direct-reading instruments and real-time data analysis are encouraged. Air contaminant studies in unique work settings are also of significant interest, as well as studies that involve emerging technologies.

Manuscripts on the use of statistical techniques to determine an employee's overall exposure profile and distribution would also be of special interest.

Guest Editors

Prof. Dr. Rodney G. Handy

Occupational and Environmental Health, Department of Family and Preventive Medicine, University of Utah, Salt Lake City, UT 84108, USA

Dr. Darrah K. Sleeth

Occupational and Environmental Health, Department of Family and Preventive Medicine, University of Utah, Salt Lake City, UT 84108, USA

Deadline for manuscript submissions

closed (30 April 2024)



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Editor-in-Chief

Dr. Ling Tim Wong

Department of Building Environment and Energy Engineering, The Hong Kong Polytechnic University, Hong Kong, China

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